Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10597491	SIGAI ET AL.
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SEARCHED			
Class	Subclass	Date	Examiner
313	483-485, 487, 491, 493-494, 498, 503, 504, 506, 512,	11/6/2008	BML
	567, 578, 634-636, 640		

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SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search, Inspec, IEEE Xplore, ScieneDirect	11/6/2008	BML

INTERFERENCE SEARCH			
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